

SHEET 1 OF 1

<b>LIST OF ART CITED BY APPLICANT</b> <b>(PTO-1449)</b>				ATTY. DOCKET NO. K-0717		APPLN. SERIAL NO. 10/533,665	
				APPLICANT(S) Dae Rae LEE and Dae Hee JUNG			
				FILING DATE May 3, 2005		GROUP 3743	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE	
	3,785,364	01/15/1974	Reid Jr. et al.				
<b>U.S. PATENT APPLICATION PUBLICATIONS</b>							
	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS		
<b>U.S. PATENT APPLICATIONS</b>							
	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS		
<b>FOREIGN PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	CN 2428707	05/02/2001	China (English Abstract & Full Chinese Text)			X	
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)</b>							
	Chinese Patent Gazette dated July 16, 2008.						
EXAMINER				DATE CONSIDERED			
/Daniel Bernstein/				03/01/2010			

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /D.B./